

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/523,107	INOUE ET AL.	
Examiner		Art Unit		Page 1 of 1
MINH D. A		2821		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,087,757	07-2000	Honbo et al.	310/316.01
*	B	US-6,593,707	07-2003	Shih, Wen-Chu	315/277
*	C	US-6,661,181	12-2003	Shin, Chung-Hyuk	315/169.4
*	D	US-6,570,344	05-2003	Lin, Yung-Lin	315/224
*	E	US-6,087,757	07-2000	Honbo et al.	310/316.01
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.